

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1119	(cost NEAR5 risk) ((integrated ADJ circuit) OR IC)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/09/27 13:19
L2	350	L1 ASIC	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/09/27 13:19
L3	310	L2 technologies	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/09/27 13:26
L4	214	L3 display	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/09/27 13:26
S1	0	"integrated circuit technolog\$" "model\$" "simulat" "risk" "cost" "analysis"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:33
S2	0	"integrated circuit" "model\$" "simulat" "risk" "cost" "analysis"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:48
S3	1	"integrated circuit" "model\$" "simulat" "analysis"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:50
S4	64247	"integrated circuit" ("model\$" OR "simulat\$")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:51

## EAST Search History

S5	4590	"integrated circuit" ("model\$" OR "simulat\$") "cost" "risk"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:51
S6	1	"integrated circuit" ("model\$" OR "simulat\$") "cost" "risk" "analy\$"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 15:53
S7	1	"integrated circuit" "cost" "risk" "analy\$"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 16:24
S8	196	"integrated circuit" "cost" "risk" "anal\$"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 16:26
S9	4654	"integrated circuit" "cost" "risk" "analysis"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 16:35
S10	3181	"integrated circuit" "cost" "risk" "analysis" (model\$ OR simulat\$)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/13 16:35
S11	17667	"integrated circuit" SAME ("cost" or "risk")	USPAT	OR	OFF	2006/06/14 07:41
S13	2157	"integrated circuit" SAME ("cost" or "risk") SAME "method"	USPAT	OR	OFF	2006/06/14 07:43
S14	119	"integrated circuit" SAME ("cost" or "risk") SAME "model\$"	USPAT	OR	OFF	2006/06/14 08:28
S15	127	integrated circuit.TI. ("cost" or "risk") SAME "model\$"	USPAT	AND	OFF	2006/06/14 07:44
S16	486	integrated circuit.AB. ("cost" or "risk") SAME "model\$"	USPAT	AND	OFF	2006/06/14 08:00
S17	211	("integrated circuit" OR "IC") SAME ("cost" or "risk") SAME "model\$"	USPAT	OR	OFF	2006/06/14 08:00

## EAST Search History

S23	7	("cost analysis".TI. OR "risk analysis".TI.) AND ("integrated circuit" OR "IC")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:13
S26	16	("cost analysis".TI. OR "risk analysis".TI.) AND "comparing"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:12
S27	15	("cost analysis".TI. OR "risk analysis".TI.) AND "technology"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:07
S28	6	("cost analysis".TI. OR "risk analysis".TI.) AND "comparing" AND "technology"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:08
S29	3	("analysis".TI.) AND ("risk".TI.) AND ("cost".TI.)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:12
S30	0	("cost analysis".TI. OR "risk analysis".TI.) AND "slid\$"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:14
S31	12	("cost analysis".TI. OR "risk analysis".TI.) AND "graph\$"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:14
S32	1	("cost analysis software" OR "risk analysis software") SAME ("input" OR "output")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:33

## EAST Search History

S33	4	(compar\$6 ADJ technolog\$ ) AND ("cost analysis" OR "risk analysis")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:36
S34	0	(compar\$6 ADJ technolog\$ ) AND ("cost ADJ analysis" OR "risk ADJ analysis")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:36
S35	0	(compare ADJ technologies ) AND ("cost ADJ analysis" OR "risk ADJ analysis")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:36
S36	0	(compar\$3 ADJ technolog\$) AND ("cost ADJ analysis" OR "risk ADJ analysis")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:37
S37	0	("cost ADJ analysis" AND "risk ADJ analysis") AND "integrated ADJ circuit"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:51
S39	1042	(cost NEAR5 risk) ((integrated ADJ circuit) OR IC)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/09/27 12:12
S40	645	(cost NEAR5 risk) ((integrated ADJ circuit) OR IC) output input	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 08:57
S41	915	(cost NEAR5 risk) computer software variable technolog\$ output input	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 09:00

## EAST Search History

S42	826	(cost NEAR5 risk) computer software variable technolog\$ output input compar\$7	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 09:00
S43	0	"integrated ADJ circuit"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:27
S44	0	"integrated ADJ circuit"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:27
S45	613309	"integrated circuit"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:27
S46	188417	S45 AND technology	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:27
S47	8891	S46 AND cost AND risk	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:28
S48	274	S47 AND (technology SAME cost SAME risk)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/14 15:29
S49	2	"6795800".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/15 14:29

## EAST Search History

S54	17	"5247468" Henrichs	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/22 16:09
S55	9	compare same risk same cost same circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/19 13:41
S56	223	compare same risk same cost	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/19 13:41
S57	18581	input value slid\$4 (real ADJ time)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/21 08:41
S58	102	input SAME value SAME slid\$4 SAME (real ADJ time)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/21 08:42
S59	13	(input SAME value SAME slid\$4 SAME (real ADJ time)) and integrated ADJ circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/21 08:51
S60	13	(input SAME value SAME slid\$4 SAME (real ADJ time)) and (graph or display or chart) and integrated ADJ circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/21 08:55
S61	11	(input SAME value SAME slid\$4 SAME (real ADJ time)) and (graph or display or chart) and (dynamic\$4 or instant\$6 or immediat\$4) and integrated ADJ circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/21 12:55

## EAST Search History

S69	2	"5247468".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/22 16:11
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